

ZnO and ZnO:Ga Ceramics for Advanced Scintillators

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Abstract: The undoped ZnO reveals narrow luminescence bands located close to fundamental absorption edge, known as near band luminescence (NBL) and defects related wide luminescence band within visible range of spectrum. NBL decay is in sub-nanosecond range and it is promising for fast scintillator development. However, the defects luminescence decay is in microsecond range and it is disturbing for fast scintillators. Dopants strongly change the luminescence properties, mainly the intensity and decay time and that is the cause for intense study of doped ZnO luminescence properties. Thus the study of luminescent properties of undoped ZnO and doped ZnO:Ga ceramics was carried out. The dependence of the radioluminescence intensity on temperature and spectrum of near band edge luminescence were examined. NBL spectra comparison of ZnO and ZnO:Ga ceramics with ZnO:Ga single crystal allowed drawn out that at 300 K the donor-acceptor pair luminescence is dominant. It was suggested that the reabsorption within band edge spectral region could significantly affected the near band luminescence intensity and spectral position at 300 K. The significant impact of gallium on the ZnO luminescence is observed. The decay kinetics of luminescence were studied in picosecond range and the two-stage luminescence decay was found for undoped ZnO. The fastest decay stage time is determined to be within 37 – 57 ps. One stage decay kinetics of NBL was determined for ZnO:Ga ceramic and decay time of 17 ps was estimated.

Keywords: ZnO, ZnO:Ga, Fast Luminescence, Decay kinetics, Radioluminescence, Scintillator

1. Introduction

ZnO is a wide-band semiconductor with band gap energy of 3.37 eV and large exciton binding energy - 60 meV. ZnO can be found in a large number of applications – as catalysts, ceramic varistors, cosmetics, solar cell semi-transparent windows, gas sensors, detectors and many other [1-5]. Various applications require quality ZnO nanoparticles and it depends on synthesis procedure as well as on dopands [6]. The ZnO has been known also as a promising fast scintillator for over forty years [7]. In addition, high exciton binding energy allows observation of the excitonic related luminescence even at room temperature. The low temperature excitonic luminescence is widely studied and the bands observed were interpreted in detail [8-11].

The near band luminescence (NBL) at 300 K is studied extensively in ZnO single crystals, films and lately in ceramics, including semi-transparent ceramics [12-16]. It was found that the powdered zinc oxide doped with gallium possesses a short de-excitation time of 0.7 ns and a high luminous yield up to 15 000 photons/MeV [17]. However, the use of powders as scintillators meet technical problems, therefore the study of ZnO single crystals as well as ceramics is of importance. The ZnO single crystal is good material for fast scintillator pulses detection – it reveals rise-times of less than 100 ps, and fall times below 1 ns; however, the growth of the qualitative single crystal is not easy [18]. The study of fast scintillators required advanced technics application since the rise time and decay time of scintillation pulses are very short. To record such short decay times of luminescence various equipment is used and

frequently the determined decay times are affected by response time of the system used, including the excitation pulse time characteristics. This is one of the possible reasons for the large variation in the published results of the ZnO exciton related luminescence decay time. Also, very important factors affecting the temporal characteristics are the morphology of the samples (powder, film, ceramic and etc.), post-synthesis thermal treatment of samples, the impurity and host defects content in composition.

The most popular dopants are Ga, In, or Al, all them act as donors; the incorporation of these dopants affects the intensity of excitonic luminescence and electric conductivity, especially if the concentration of donor centers increases [1, 19]. The important and still unanswered is the question how the impurity ions are embedded in nanocrystals and ceramics grains and its boundaries. The distribution of dopants in nanopowders and ceramics is the subject of many studies.

Despite of many studies, details of scintillation mechanism at 300 K remains unknown. The NBL at 3.18 eV showed the fast decay, previously characterized in ZnO as well as in ZnO:Ga single crystal samples [20, 21]. The proposed mechanism includes DAP recombination and indicates the presence of both – donor centers and acceptor centers also. The DAP decay is not simply exponential and decay down to 50% from initial intensity occur within 5,5 ns in undoped and nitrogen doped single crystals at 16 K [22]. Efficient ultrafast scintillations have been observed in ZnO:Ga and ZnO:In compositions [18, 23]. It is known that the unexpected impurities as well as doping greatly affect the scintillation response time. It was demonstrated that in undoped ZnO single crystals the luminescence decay time varies between 130 ps and 1.7 ns, whereas in ZnO:In single crystal the response time of 15 ps was achieved [24].

The NBL intensity fast decay over four orders of magnitude, that could be estimated and it indicate the doped ZnO ceramics are promising for scintillators [10, 25]. It is known that in ceramics the fundamental absorption edge is usually shifted to the low-energy side of the spectrum. This is due to the structural disorder or disorder related to dopants. The position of fundamental absorption edge is affected by morphology and particle size. The luminescence decay curves for hot pressed ceramics ZnO doped with Ga were recorded under pulsed X-ray excitation using the time-correlated photon counting detection system [26, 27]. The estimated decay time obtained for NBL band was 0.7 ns. It is a good result, since ZnO ceramic is of interest for its use as the scintillation detector. However, it is necessary to improve the structural, mechanical and luminescent properties of ZnO ceramics, bringing them to perfection.

The present research is motivated by the need for better understanding of the scintillations nature in ZnO and ZnO:Ga ceramics sintered by uniaxial hot pressing, as well as estimate luminescence decay time. Therefore the NBL of ceramics is studied and for comparison the ZnO:Ga single crystal is used. The defect luminescence in green/yellow spectral region was not studied in this paper. The time-resolved luminescence studies under picosecond excitation were used for the study of

luminescence decay process.

2. Experimental

The ceramic samples were made from powders obtained by hydrothermal method followed by annealing at 850°C in air. The sintering of ceramics was conducted by uniaxial hot pressing of powder in vacuum at 1100°C under pressure 150 MPa. The ceramics samples for experiments were disks with 24 mm diameter and ~0.5 mm thickness. The sintering technology was described in detail in [27]. The undoped ZnO ceramics and doped ZnO:Ga (0.1 wt.% Ga) ceramics were used in the present study. The ZnO:Ga single crystal was used for luminescence spectra comparison.

Microstructure and fracture mode of ceramics were studied by optical (Nicon Eclipse 120) microscope and scanning electron (SEM, Phenom Pro) microscope. The crystallinity of ceramics was determined by XRD using a Rigaku MiniFlex 600 X-ray diffractometer. Cu K α radiation was used by setting the cathode voltage to 40 kV and current to 15 mA.

Photoluminescence was excited using 266 nm wavelength-tuneable picosecond solid state laser, FWHM of pulse is 24 ps, fall time 17 ps between intensity levels 0.9–0.1, pulse energy of around 160 μ J/cm². The laser beam was focused on the sample using convex lens. Laser beam spot size was around 6 mm². Bruker 250IS/SM spectrograph with grating 150 l/mm at blaze 300 nm was used for spectral region selection. The spectra excited with laser pulses were measured within time range 0 \div 1 ns (where 0 ns is laser pulse start time).

The time integrated radioluminescence spectra were measured under x-ray excitation. X-ray tube with tungsten anode was operated at 30 kV and 10 mA. The spectra of luminescence were recorded using Andor Shamrock B-303i spectrograph equipped with Andor DV-401A-BV CCD camera.

3. Results and Discussion

3.1. Crystalline Structure

The ZnO:Ga ceramics XRD pattern was recorded at RT for 2 θ within 10 – 70 degrees. Obtained XRD data matches well with those of card JCPDS 036-1451 (Figure 1) indicating that ceramics grains have hexagonal wurtzite structure.

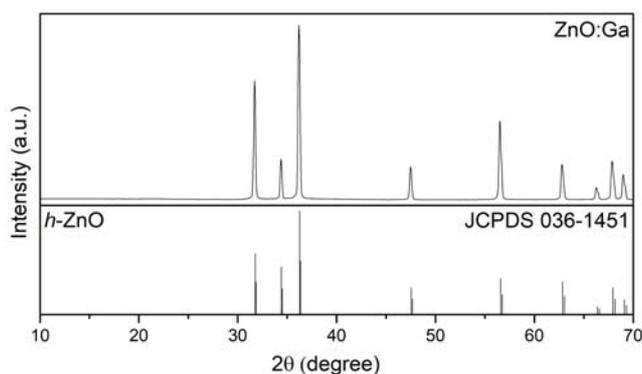


Figure 1. XRD pattern of ZnO:Ga ceramics.

The other phases were not detected and it confirms the Ga substitutes for Zn in ZnO wurtzite structure. Therefore in ZnO:Ga ceramics the additional donor levels were introduced [28]. Undoped ZnO ceramics have wurtzite structure also.

3.2. Microstructure of Ceramics

The microstructure of both undoped and doped ceramics is very heterogeneous in grain size: $d_g = 5\text{--}25\ \mu\text{m}$ in ZnO ceramic and $d_g = 2,5\text{--}22\ \mu\text{m}$ in ZnO:Ga ceramic (Figure 2a, b). In Ga doped ZnO ceramics the grains are a little smaller than those in undoped ZnO ceramic. Moreover, there is a tendency to change the shape of some grains. True, not to the same extent, as under the influence of indium, however, this process is noticeable and according to known mechanisms of the sintering process, can be associated with the gallium influence on the grain growth stage [15, 29, 30]. The effect of gallium on the ceramics structure formation is confirmed by the SEM images of fracture mode results (Figure 2c, d).

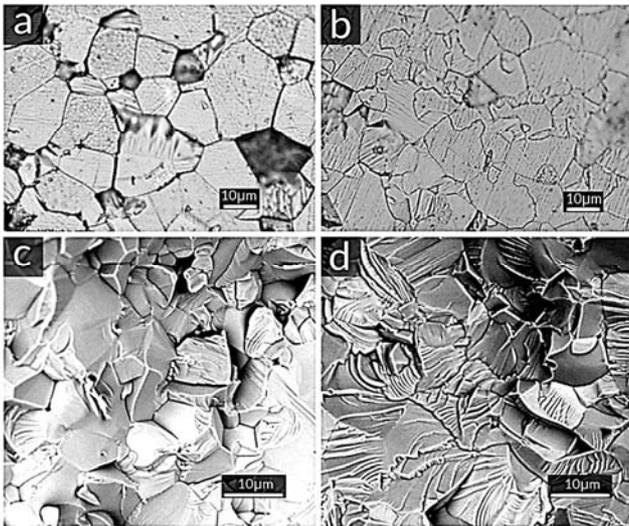


Figure 2. Micrographs of etched surfaces (a, b), and SEM images of fracture surfaces (c, d) of undoped (a, c) and Ga doped (b, d) ceramics.

As one can see, undoped ZnO ceramic sample has mainly intergranular fracture mode (Figure 2, c). At the same time, gallium-doped ceramic sample is characterized by predominant brittle transcrystalline fracture (Figure 2, d) with many steps of cleavage inside the grains. Appearance of these fractures elements is due gallium-induced change the nature of the cracks propagation, which in turn indicates a new structural state of ceramics. As shown by Vorobyeva N. et al, the formation of compounds or ZnO + Ga₂O₃ solid solution is possible when doping ZnO with Ga₂O₃, leading to the increased manifestation of the donor properties of gallium, however XRD showed only the wurtzite phase of ceramic samples used in the present study [31].

Micropores and voids are also visible in the microstructures of both undoped and gallium doped samples, which for ZnO ceramics is a characteristic consequence of powder agglomeration processes, reinforced in this case by preliminary annealing of powders at 850°C [29].

The presence of these defects determined the semi-transparency of ceramics obtained for this study: for undoped ZnO ceramic the transparency is $\sim 15\%$ at 500 nm, at the same time, others ZnO samples where powders agglomeration was not so intense showed transparency close to 60% at 500 nm [15].

The influence of morphology and grain size of ceramics properties is significant and it is known that the fundamental absorption edge of ceramics is shifted to the low-energy side of the spectrum due to the ceramics structural disorder and disorder related to dopants [15, 16].

3.3. Luminescence

3.3.1. Radioluminescence

The radioluminescence shows all luminescence processes under band-to-band excitation. The radioluminescence spectra of ZnO:Ga single crystal and ceramics were recorded under continuous X-ray excitation at different temperatures. The NBL was observed for both materials, however the spectra differ significantly (Figure 3).

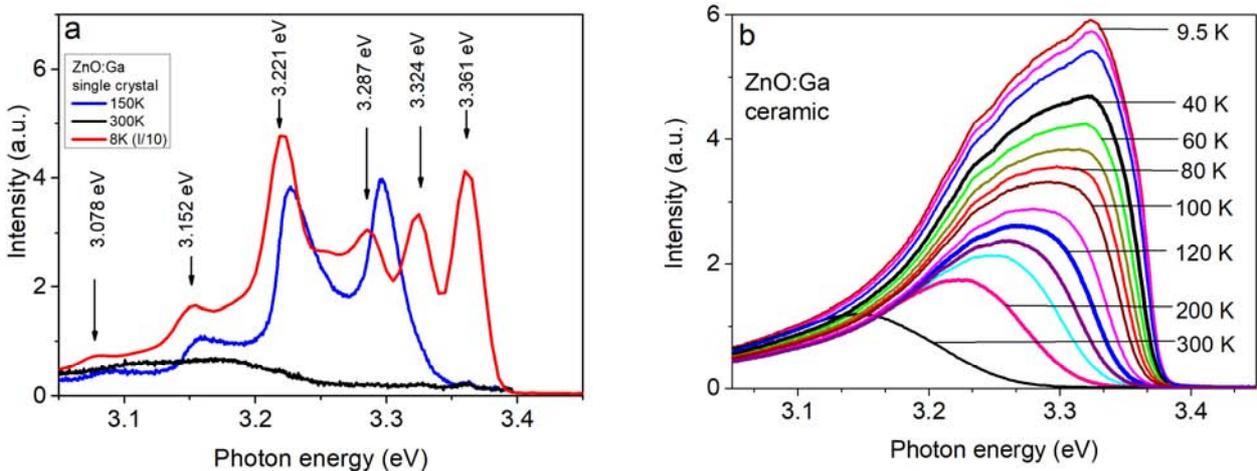


Figure 3. Radioluminescence spectra of ZnO:Ga single crystal (a) and ZnO:Ga ceramics at different temperatures (b).

The NBL spectrum of ZnO:Ga single crystal at 8 K reveals

six narrow bands and is similar to that of ZnO single crystal

described in [1, 10]. The position of ExD^0 luminescence peak at 8 K in high quality ZnO single crystal is at 3.3605 eV [1]. In ZnO:Ga single crystal this peak position is at 3.361 eV (Figure 3a) and it is close to position in undoped crystal. The positions of other peaks are close to those observed in undoped crystal also. Therefore, the interpretation of luminescence bands is the same as found by Ozgur, U. et al and Meyer, B. K. et al and

corresponding bands positions, its origin and marks are in the Table 1, [1, 10]. The longitudinal optical phonon (LO) energy is 0.072 eV in ZnO and even in nanocrystals LO phonon energy is the same [32, 33]. Therefore, the LO phonon replicas positions of corresponding luminescence bands were estimated from the spectrum in Figure 3a.

Table 1. Luminescence bands of ZnO:Ga single crystal at 8 K.

Band position, eV	Origin of band	Marks used in the text
3.361	Exciton bound at neutral donor	ExD^0
3.324	Two-electron satellite of exciton bound at neutral donor	TES ExD^0
3.287	1LO phonon replica of the exciton bound at neutral donor	1LO- ExD^0
3.221	Donor-Acceptor-Pair transition	DAP
3.152	1LO phonon replica of the Donor-Acceptor-Pair transition	1LO-DAP
3.078	2LO phonon replica of the Donor-Acceptor-Pair transition	2 LO-DAP

One could note that the position of luminescence band peaking at 3.221 eV is close to the position of possible 2 LO phonon replica for ExD^0 band since $3.361 - 2 \times 0.072 = 3.217$. There is a small disagreement in energy of band position, and it could arise due to accuracy of band position determination. The most important is that intensity of the band peaking at 3.221 eV significantly exceed that for 1LO- ExD^0 band. The intensity of two phonon replica must be less than that for one phonon replica, therefore the band peaking at 3.221 eV cannot be 2LO- ExD^0 replica. The position of band at 3.221 eV matches well with that for donor-acceptor pair transition (DAP) [10].

wavelength the tail of ExD^0 band is recorded. The ZnO:Ga ceramics luminescence intensity dependence on temperature for a number of photon energies is shown in Figure 4. Since intensities of luminescence covers the wide range within whole band, the normalized intensity is used. These dependencies differ suggesting that the temperature quenching of luminescence (thermal activation energies) differs also and luminescence within 3.300 – 3.338 eV shows the strongest thermal quenching.

The asymmetric shape of the ZnO:Ga ceramics luminescence band as well as luminescence intensity and the band shape dependences on temperature are the strong evidences that several bands overlaps. The overlapping luminescence bands are greatly affected by disorder of ceramics structure (positions, FWHM). In this case responsible for luminescence band components could be luminescence due to excitonic processes as well as to slightly different donor-acceptor pairs and electrons recombination with acceptors.

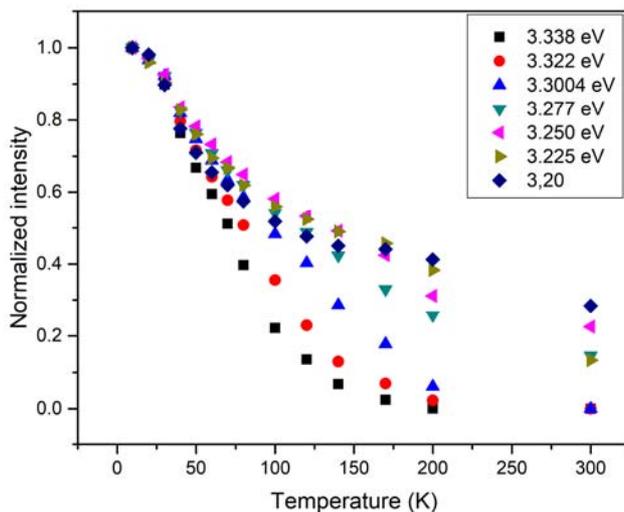


Figure 4. ZnO:Ga ceramics luminescence intensity dependence on temperature.

The ZnO:Ga ceramics showed a wide asymmetric NBL band in a wide temperature range from 9.5 K up to 300 K, Figure 3b. This luminescence band covers the same spectral range as the NBL of ZnO:Ga single crystal, Figure 3 a, b. However, the separate narrow bands were not resolved in ZnO:Ga ceramics spectra and high energy side of the band could be hidden under fundamental absorption edge. At 9.5 K the ZnO:Ga ceramics luminescence is cut off at ~ 3.38 eV (Figure 3b), whereas in single crystal luminescence at this

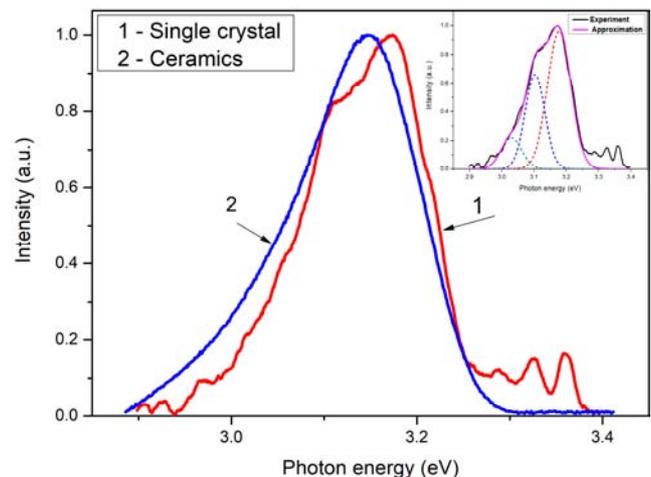


Figure 5. ZnO:Ga radioluminescence spectra at 300 K, a single crystal – 1, ceramics – 2; inset - approximation of single crystal luminescence spectrum by 3 Gaussians.

The similar asymmetric luminescence band was observed by K. A. Chernenko et al. [15]. The possible contributions

from bound excitons recombination and others (ExD^0 , ExD^+ , at lattice defects, DAP, etc.) could be suggested. The attempts to decompose NBL band was carried out by D. Das and P. Mondal and the best fit to experiment was reached by using 5 or 6 Gaussians for approximation [34, 35]. However, the possible overlapping of luminescence band with fundamental absorption edge there was not taken into account. Hence there is not a strong ground that this set of Gaussians is only possible version for experimental spectrum approximation. One could note a large number of variables - each Gaussian have 3 variables (position, amplitude and FWHM), hence up to 15 or 18 variables can be used for deconvolution of experimental curve and therefore the interpretation of components found could be ambiguous.

The room temperature luminescence is most important for scintillators. The ZnO:Ga single crystal and ceramics radioluminescence spectra at 300 K both covers the same spectral range peaking within 3.12 – 3.19 eV (Figure 5), however the spectra were not the same. The spectrum of single crystals reveals well resolved bands of ExD^0 , TES ExD^0 and 1LO-ExD^0 luminescence within 3.25 – 3.40 eV range. The intensities of these bands were reduced due to thermal quenching. The more intense luminescence band of ZnO:Ga single crystal is peaking at 3.18 eV and has a shoulder within 3.094 – 3.136 eV, thus the band is complex. This luminescence

band can be approximated with a sum of three Gaussians (inset of Figure 5) peaking at 3.032, 3.104 and 3.178 eV. These positions are close to the DAP bands recorded at 8 K (Figure 3a, Table 1.), however the positions were slightly shifted to long wave side. The dominant DAP luminescence was observed for ZnO:Ga thin films at room temperature [36]. Therefore, it is suggested the ZnO:Ga ceramics NBL at room temperature is from donor-acceptor-pairs transitions also.

The ZnO:Ga ceramics radioluminescence spectrum at 300 K contains one structureless band peaking at 3.147 eV. There was not any luminescence band above 3.3 eV, possibly this range is covered by a strong fundamental absorption. The disorder in ceramics is a reason for luminescence bands widening and shifting, thus the shoulder of band, similar to that observed for single crystal, is not revealed, however luminescence band is asymmetric. Therefore the main contribution in ZnO:Ga single crystal and ceramics radioluminescence at 300 K is from donor-acceptor-pairs transitions.

3.3.2. Photoluminescence Under Picosecond Excitation

Figure 6 (a) and (b) shows the streak camera images of photoluminescence at RT for undoped ZnO ceramic and doped ZnO:Ga respectively. The faster decay process was observed for ZnO:Ga ceramic (Figure 6 b).

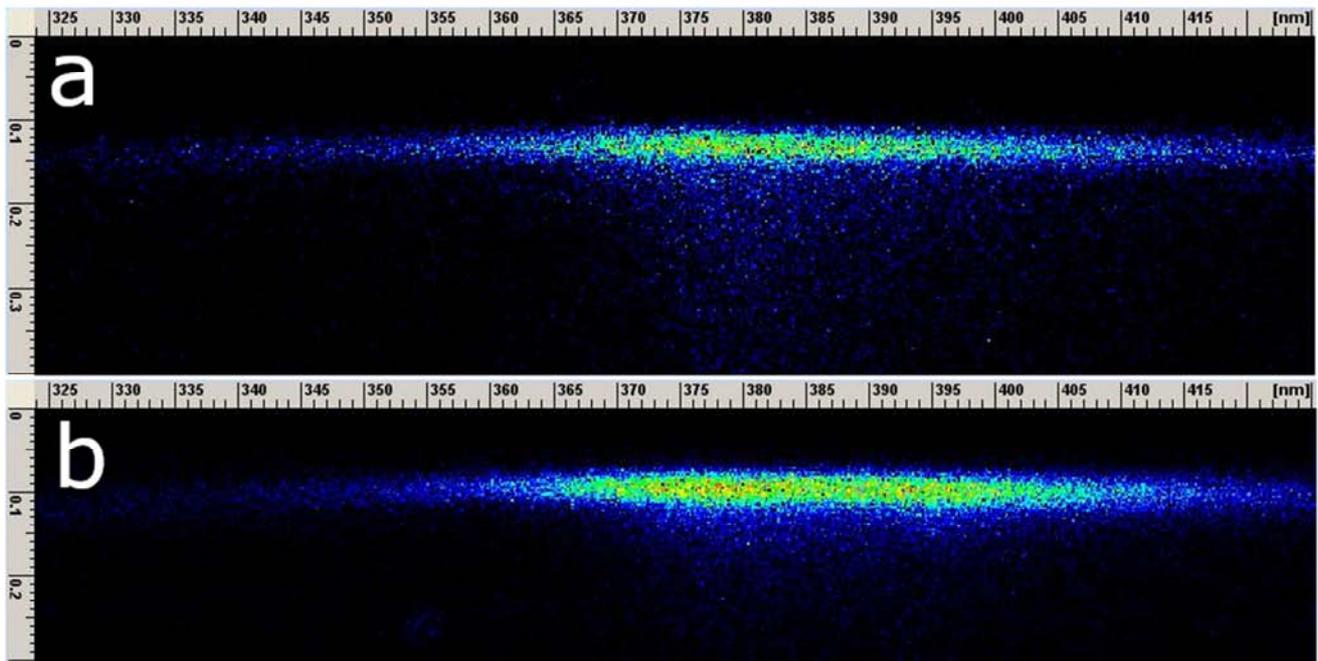


Figure 6. Streak camera images of ZnO undoped ceramic (a) and ZnO:Ga ceramic (b) in NBL spectral region. In (a) the time range is 0-0.4 ns and in (b) the time range is 0-0.3 ns. (wavelength axis in nm horizontal, time axis in ns vertical).

The luminescence spectra at room temperature under picosecond excitation in NBL spectral region are shown for three samples in Figure 7. The luminescence spectra for single crystal and for both ceramics contained a complex band. A detailed analysis of the spectra showed that at least two (possibly more) bands overlapped in each spectrum. The single crystal photoluminescence spectrum matches well with

that of radioluminescence at 300 K (Figure 5.), the shoulder at 3.1 eV is an evidence of luminescence bands overlapping. The spectrum of ZnO:Ga ceramics differs from that of radioluminescence – two overlapping bands can be resolved peaking at ~ 3.14 eV and ~ 3.28 eV. The peak position at 3.14 eV is the same as in radioluminescence spectrum, whereas at 300 K there was not resolved as possible separate

radioluminescence band at 3.28 eV. It is noted that peak position at 3.28 eV is close to the ExD° band position in ZnO:Ga single crystal at 8 K. The peak position shifts to the longer wavelength could be due to higher temperature as well as due to disorder in ZnO:Ga ceramics structure. The absence of this peak in radioluminescence spectrum is related to the shorter life time of ExD° complex. Thus, we assume in ZnO:Ga ceramics the ExD° is responsible for luminescence band peaking at ~ 3.28 eV.

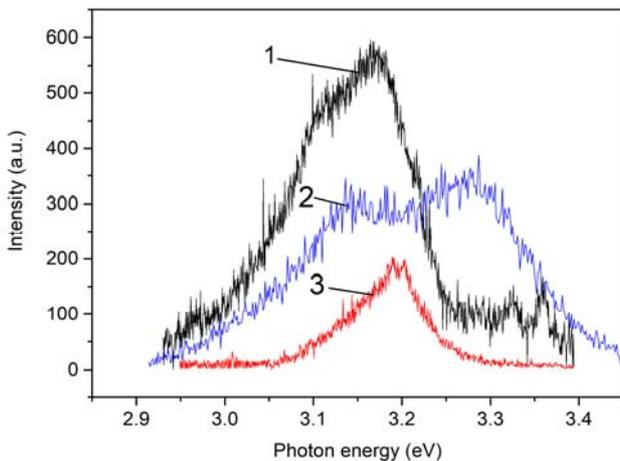


Figure 7. Time-integrated (1 ns) photoluminescence spectra: 1 – ZnO:Ga single crystal, 2 – ZnO:Ga ceramic, 3 – ZnO undoped ceramic at 300K, 266 nm excitation.

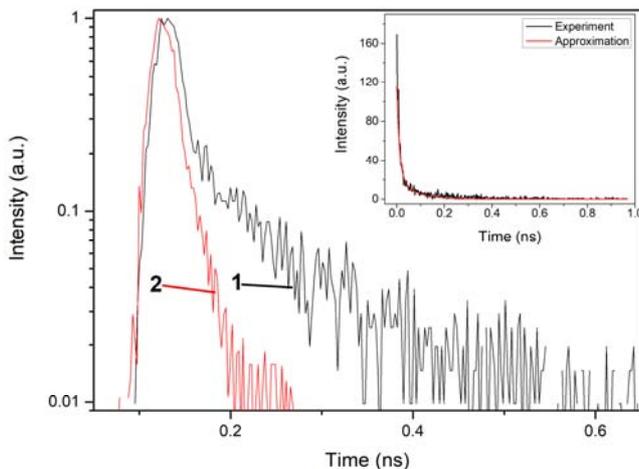


Figure 8. The luminescence kinetics of ceramics: 1- undoped ZnO, 2- ZnO:Ga. Inset – undoped ZnO luminescence decay at 3.29 eV approximation with 2 exponents.

3.3.3. Luminescence Decay Kinetics in 1 ns Time Scale

The analysis of decay kinetics was performed in models of single and two exponential functions. Two exponential decay process is observed in ZnO single crystal for both luminescence bands [20]. The fitting allows estimation of decay times and to determine is there one or several processes involved. In Figure 8 the luminescence kinetics measured at 3.29 eV for undoped ZnO and doped ZnO:Ga ceramics are shown. The slowest decay of luminescence is for undoped ZnO ceramics. Therefore, doping with Ga

resulted in significantly shorter decay kinetic thus making the material more prospective for fast operating scintillators. A similar effect was observed in ZnO:In ceramic [25].

The two-exponent decay of luminescence was observed in range 3.10 – 3.25 eV in ZnO:Ga single crystal and undoped ZnO ceramic. The undoped ZnO ceramics luminescence decay approximation with 2 exponents is shown in the inset in Figure 8. In this case there is a fast component with decay times within 37-57 ps and slow component with decay times in range 65-115 ps. The origin of two components of decay kinetics is slightly different donor – acceptor pairs, possibly due to diverse nearest surrounding of pairs. Therefore, the overlapping luminescence bands contributed in spectrum (Figure 5, inset). In ZnO:Ga ceramic in 3.29-3.33 eV region only one decay component is detected with decay time constant 17 ps, whereas at 3.1 eV the fast decay time constant 19 ps is estimated and additionally slower decay with time constant 97 ps appear. However, the intensity of this component does not exceed $\sim 7\%$ of total luminescence intensity. The value of ZnO:Ga ceramics NBL decay time 17 ps is close to that (15 ps) found for ZnO:In, therefore both compositions are promising for advanced scintillators [24]. The analysis of ZnO:Ga ceramics NBL decay suggest that in short wave range contribution from ExD° luminescence is and possible donor could be Gallium, since in undoped ZnO ceramics NBL spectrum was not observed band peaking at ~ 3.28 eV. Deconvolution procedure was not performed for luminescence decay analysis and 17 ps is the time resolution limit of equipment used. This limit is determined by laser pulse. Therefore, it cannot be excluded that really ZnO:Ga ceramics luminescence decay could be faster.

4. Summary

The NBL in ZnO:Ga single crystal and ZnO:Ga ceramics covered the same spectral region. It is shown that the NBL at 300 K is due to the luminescence of the DAP, additionally at 3.28 eV the ExD° is suggested. The luminescence spectrum of ZnO:Ga single crystal at 300 K can be well approximated with 3 overlapping Gaussians (at ~ 3.032 eV, 3.104 eV and ~ 3.178 eV) exhibiting sub-nanosecond decay times. The morphology of samples gave an evidence that ZnO:Ga ceramics is more disordered than undoped ZnO ceramics. The doping of ZnO with Ga shortens the decay time considerably and it was estimated to be within 17 – 19 ps, while undoped ZnO ceramic sample shows 37-57 ps decay time for faster component (depending on the spectral position of the scintillation).

Further development of the technology for manufacturing of transparent ZnO and ZnO:Ga ceramics (by using the uniform initial powder, increasing the transparency and homogeneity of ceramics) will provide an opportunity to obtain scintillation material with picosecond characteristics and intense luminescence signal.

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AIP Publishing Data Sharing Policy

The data that support the findings of this study are available from the corresponding author upon reasonable request.

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